Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,377	AWAD ET AL.	
Examiner	Art Unit	
DANH C. LE	2617	

SEARCHED				
Class	Subclass	Date	Examiner	
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	INTERFERENCE SEARCHED				
Subclass	Date	Examiner			
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search (Check for double patenting) EAST Search (US, USPUB)	7/2/06	DCL	